

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	09/763,362	TOMIZUKA ET AL.
	<b>Examiner</b> Thaian N. Ton	<b>Art Unit</b> 1632

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner